## Search Notes



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Examiner

Loewe, Sun Jae Y

Art Unit

Reexamination

DEYN ET AL.

Applicant(s)/Patent Under

1626

## **SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES**

Search Notes	Date	Examiner
restriction requirement	10-4-07	sl

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner
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